# MOSFET – Power, Single P-Channel -60 V, -6 A, 260 mΩ

#### Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVTFS5124PLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

		,		
Parameter				Unit
Drain-to-Source Voltage				
Gate-to-Source Voltage				
	T <sub>mb</sub> = 25°C	۱ <sub>D</sub>	-6.0	А
Steady	$T_{mb} = 100^{\circ}C$		-4.0	
State	T <sub>mb</sub> = 25°C	PD	18	W
	$T_{mb} = 100^{\circ}C$		9.0	1
	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	-2.4	А
Steady State	T <sub>A</sub> = 100°C		-1.7	1
	T <sub>A</sub> = 25°C	PD	3.0	W
	T <sub>A</sub> = 100°C		1.5	1
T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	-24	А
Storage T	emperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
iode)		۱ <sub>S</sub>	-18	А
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = -50 V, V <sub>GS</sub> = -10 V, I <sub>L(pk)</sub> = -13 A, L = 0.1 mH, R <sub>G</sub> = 25 $\Omega$ )				mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				°C
	steady Steady State State $T_A = 25$ Storage T iode) Source Av = -50 V, H, R <sub>G</sub> = 2 poldering F	heter e Tmb = 25°C Tmb = 100°C Tmb = 25°C Tmb = 100°C Tmb = 100°C Tmb = 25°C Tmb = 100°C Tmb = 100°C Tmb = 25°C Tmb = 100°C Tmb = 25°C Tmb = 100°C Tmb = 100°C	SymbolSymbolVossVossVossVossVossVossVossVossSteady Tmb = 100°CTmb = 25°CIDTmb = 100°CPDTmb = 100°CIDTa = 25°CIDTa = 25°CPDTa = 100°CPDTa = 100°CIDMSteady Ta = 100°CTa = 25°C, tp = 10 µsIDMStorage TemperatureIsSource Avalanche = -50 V, VGS = -10 V, H, RG = 25 $\Omega$ Didering PurposesTL	$\begin{array}{c c c c c } & & & & & & & & & & & & & & & & & & &$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) – Steady State (Note 2 and 3)	$R_{\PsiJ-mb}$	8.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	49.2	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

- 2. Psi  $(\Psi)$  is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

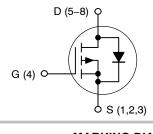


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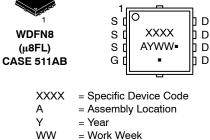
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
–60 V	260 mΩ @ –10 V	-6 A
	380 mΩ @ −4.5 V	-07

P-Channel MOSFET



# MARKING DIAGRAM



= Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

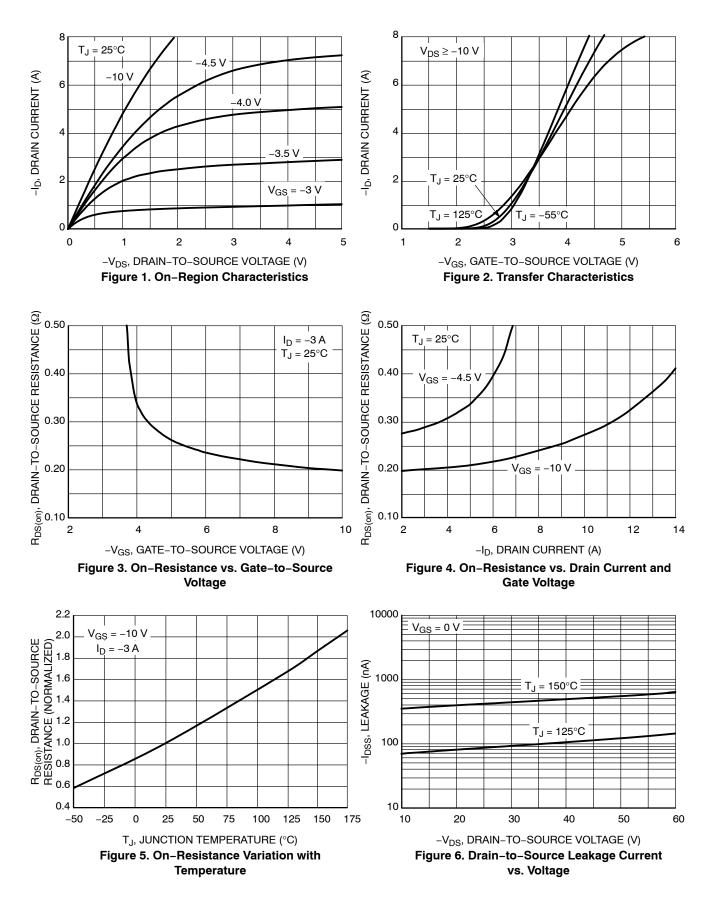
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

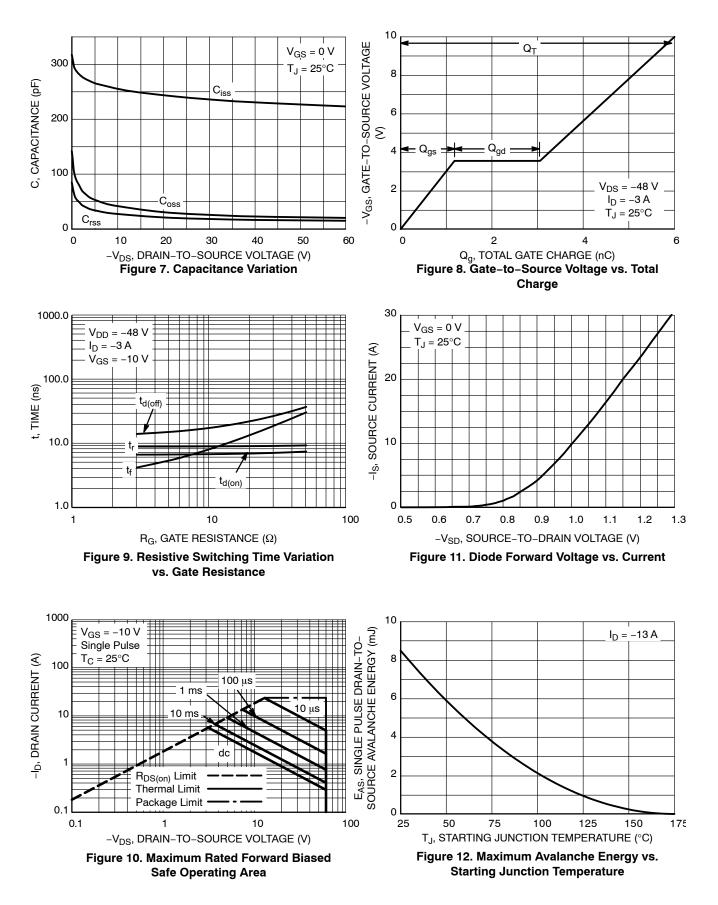
Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_{D}$ = -250 $\mu$ A		-60			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1.0	μA
		$V_{DS} = -60 V$	T <sub>J</sub> = 125°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$	= ±20 V			± 100	nA
ON CHARACTERISTICS (Note 5)					•		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} =$	= –250 μA	-1.5		-2.5	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I	<sub>D</sub> = -3 A		200	260	mΩ
		V <sub>GS</sub> = -4.5 V,	<sub>D</sub> = -3 A		290	380	
Forward Transconductance	9fs	V <sub>DS</sub> = -15 V, I	<sub>D</sub> = -5 A	4			S
CHARGES AND CAPACITANCES					•		
Input Capacitance	C <sub>iss</sub>				250		
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = <sup>-</sup> V <sub>DS</sub> = -2	.0 MHz, 5 V		27		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	V <sub>DS</sub> = -25 V			17		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = -4.5 V, $V_{DS}$ = -48 V, I <sub>D</sub> = -3 A			3.5		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.4		
Gate-to-Source Charge	Q <sub>GS</sub>				1.2		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.9		
Total Gate Charge	Q <sub>G(TOT)</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = -10 \text{ V},  V_{DS} = -48 \text{ V}, \\ I_D = -3 \text{ A} \end{array}$			6		
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t <sub>d(on)</sub>				7		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>D</sub>	s = -48 V.		14		ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = -3  \rm A,  R_{\rm G}$	= 2.5 Ω		13		
Fall Time	t <sub>f</sub>				10		1
DRAIN-SOURCE DIODE CHARACTEF	ISTICS				•		
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$ $I_{S} = -3 A$	$T_J = 25^{\circ}C$		-0.87	-1.0	V
			T <sub>J</sub> = 125°C		-0.74		
Reverse Recovery Time	t <sub>RR</sub>	$\begin{array}{l} V_{GS}=0 \text{ V},\\ dI_S/dt=100 \text{ A}/\mu\text{s},\\ I_S=-3 \text{ A} \end{array}$			17		ns
Charge Time	t <sub>a</sub>				14		1
Discharge Time	t <sub>b</sub>				3		1
Reverse Recovery Charge	Q <sub>RR</sub>				19		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



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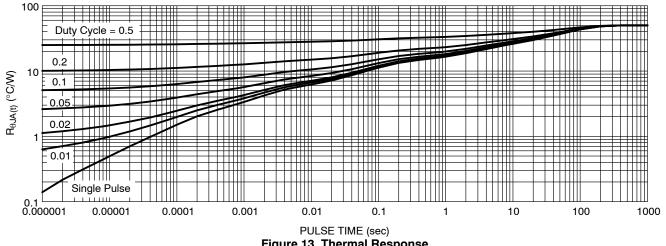


Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS5124PLTAG	5124	WDFN8 (Pb–Free)	1500 / Tape & Reel
NVTFS5124PLWFTAG	24LW	WDFN8 (Pb–Free)	1500 / Tape & Reel
NVTFS5124PLTWG	5124	WDFN8 (Pb-Free)	5000 / Tape & Reel
NVTFS5124PLWFTWG	24LW	WDFN8 (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





Pb-Free indicator, "G" or microdot " .", may or may not be present.

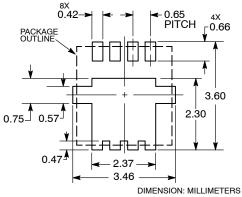
DATE 23 APR 2012

NOTES:

LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2. 3.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
с	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC			.130 BSC	)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
К	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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